

CMOS Digital Integrated Circuits Silicon Monolithic

# 74HC4053FT

### 1. Functional Description

· Triple 2-Channel Analog Multiplexer/Demultiplexer

#### 2. General

The 74HC4053FT is high speed CMOS ANALOG MULTIPLEXER/DEMULTIPLEXER fabricated with silicon gate CMOS technology. They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

The 74HC4053FT has a 2 channel  $\times$  3 configuration.

The digital signal to the control terminal turns "ON" the corresponding switch of each channel a large amplitude signal ( $V_{CC}$  -  $V_{EE}$ ) can then be switched by the small logical amplitude ( $V_{CC}$  - GND) control signal.

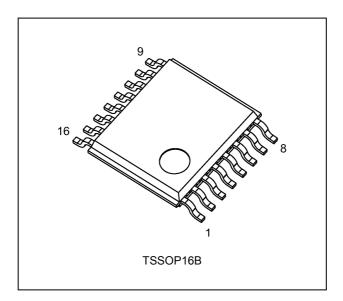
For example, in the case of  $V_{\rm CC}$  = 5 V, GND = 0 V,  $V_{\rm EE}$  = -5 V, signals between -5 V and +5 V can be switched from the logical circuit with a single power supply of 5 V. As the ON-resistance of each switch is low, they can be connected to circuits with low input impedance.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### 3. Features

- (1) Wide operating temperature range:  $T_{opr} = -40$  to 125 °C
- (2) Low power dissipation:  $I_{CC} = 4.0 \mu A \text{ (max)}$  ( $V_{CC} = 6.0 \text{ V}$ ,  $V_{EE} = \text{GND}$ ,  $T_a = 25 \,^{\circ}\text{C}$ )
- (3) High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- (4) Low ON-resistance:  $R_{ON} = 50 \Omega$  (typ.) at  $V_{CC}$   $V_{EE} = 9 V$
- (5) High degree of linearity: THD = 0.020 % (typ.) at  $V_{CC} V_{EE} = 9 \text{ V}$
- (6) Pin and function compatible with 4053B

### 4. Packaging

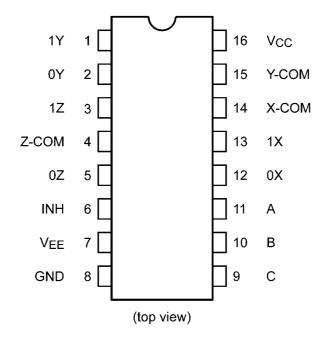


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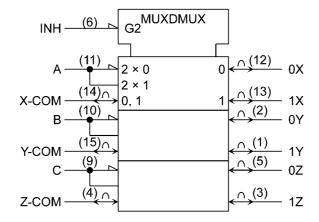
Start of commercial production



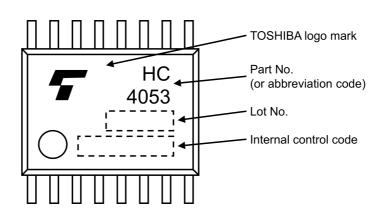
## 5. Pin Assignment



## 6. IEC Logic Symbol

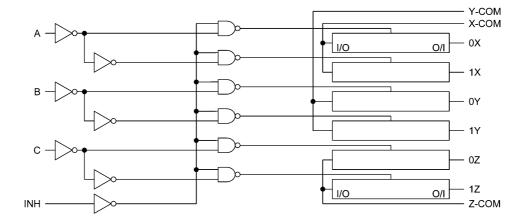


## 7. Marking





## 8. System Diagram





#### 9. Truth Table

Input Inhibit	Input C	Input B	Input A	ON Channel
L	L	L	L	0X, 0Y, 0Z
L	L	L	Н	1X, 0Y, 0Z
L	L	Н	L	0X, 1Y, 0Z
L	L	Н	Н	1X, 1Y, 0Z
L	Н	L	L	0X, 0Y, 1Z
L	Н	L	Н	1X, 0Y, 1Z
L	Н	Н	L	0X, 1Y, 1Z
L	Н	Н	Н	1X, 1Y, 1Z
Н	X	X	X	None

X: Don't care

## 10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
	V <sub>EE</sub>		-7.0 to 0	
	V <sub>CC</sub> -V <sub>EE</sub>		-0.5 to 13.0	
Input voltage	V <sub>IN</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Switch I/O voltage	V <sub>I/O</sub>		V <sub>EE</sub> - 0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>		±20	mA
I/O diode current	I <sub>I/OK</sub>		±20	mA
Switch through current	I <sub>T</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±50	mA
Power dissipation	P <sub>D</sub>	(Note 1)	180	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: 180 mW in the range of  $T_a$  = -40 to 85 °C. From  $T_a$  = 85 to 125 °C a derating factor of -3.25 mW/°C shall be applied until 50 mW.

## 11. Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2.0 to 6.0	V
	V <sub>EE</sub>	-6.0 to 0	
	V <sub>CC</sub> -V <sub>EE</sub>	2.0 to 12.0	
Input voltage	V <sub>IN</sub>	0 to V <sub>CC</sub>	V
Switch I/O voltage	V <sub>I/O</sub>	V <sub>EE</sub> to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	-40 to 125	°C
Input rise and fall times	t <sub>r</sub> ,t <sub>f</sub>	0 to 50	μS

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{CC}$  or GND.



## 12. Electrical Characteristics

# 12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	_	V
				4.5	3.15	_	_	
				6.0	4.20	_	_	
Low-level input voltage	V <sub>IL</sub>	_		2.0	_	_	0.50	V
				4.5		_	1.35	
				6.0	1	_	1.80	
ON-resistance	R <sub>ON</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	GND	4.5		85	180	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	1	55	120	
		11/0 = 2 11/A	-6.0	6.0		50	100	
		$V_{IN} = V_{IH}$ or $V_{IL}$	GND	2.0	_	150	_	
		$V_{I/O} = V_{CC}$ or $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5	_	70	150	
		11/0 = 2 11/A	-4.5	4.5	_	50	100	
			-6.0	6.0	_	45	80	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	1	10	30	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	5	12	
		11/0 = 2 11/A	-6.0	6.0	_	5	10	
Input/Output leakage current	I <sub>OFF</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	_	±0.06	μА
(Switch OFF)		$V_{IS}$ = GND or $V_{CC}$ $V_{IN}$ = $V_{IH}$ or $V_{IL}$	-6.0	6.0	_	_	±0.1	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	_	±0.06	μА
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	_	_	±0.1	
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	_	±0.1	μА
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	_	4.0	μА
			-6.0	6.0	_	_	8.0	



# 12.2. DC Characteristics (Unless otherwise specified, $T_a$ = -40 to 85 °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	$V_{IL}$	_		2.0	_	0.50	\ \
				4.5	_	1.35	
				6.0	_	1.80	
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	225	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	150	
		11//0 = 2 111/4	-6.0	6.0	_	125	
		$V_{IN} = V_{IH}$ or $V_{IL}$	GND	2.0	_	_	
		$V_{I/O} = V_{CC}$ or $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5	_	190	
		11//0 = 2 111/4	-4.5	4.5	_	125	
			-6.0	6.0	_	100	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	35	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	15	
		11//O = 2 111/A	-6.0	6.0	_	12	
Input/Output leakage current	I <sub>OFF</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±0.6	μА
(Switch OFF)		$V_{IS}$ = GND or $V_{CC}$ $V_{IN}$ = $V_{IH}$ or $V_{IL}$	-6.0	6.0	_	±1.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±0.6	μА
(Switch ON)		$V_{IN} = V_{IH}$ or $V_{IL}$	-6.0	6.0	_	±1.0	]
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±1.0	μА
Quiescent supply current	Icc	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	40.0	μА
			-6.0	6.0	_	80.0	

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# 12.3. DC Characteristics (Unless otherwise specified, $T_a$ = -40 to 125 °C)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_	•	2.0	1.50	_	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	$V_{IL}$	_	'	2.0	_	0.5	V
				4.5	_	1.35	
				6.0	_	1.8	
ON-resistance	R <sub>ON</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	255	Ω
		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	170	
		11//O = 2 111A	-6.0	6.0	_	145	
		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	2.0	_	_	Ω
		$V_{I/O} = V_{CC}$ or $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	GND	4.5	_	220	
		11//O = 2 111A	-4.5	4.5	_	145	
			-6.0	6.0	_	115	
Difference of ON-resistance	$\Delta R_{ON}$	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	GND	4.5	_	35	Ω
between switches		$V_{I/O} = V_{CC}$ to $V_{EE}$ $I_{I/O} \le 2 \text{ mA}$	-4.5	4.5	_	15	
		11//O = 2 111/A	-6.0	6.0	_	12	
Input/Output leakage current (Switch OFF)	I <sub>OFF</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND V <sub>IS</sub> = GND or V <sub>CC</sub>	GND	6.0	_	±3.0	μА
(Switch OFF)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	_	±5.0	
Input/Output leakage current	I <sub>I/O</sub>	V <sub>OS</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±3.0	μА
(Switch ON)		$V_{IN} = V_{IH} \text{ or } V_{IL}$	-6.0	6.0	_	±5.0	
Control input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	±1.0	μА
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	GND	6.0	_	80.0	μΑ
			-6.0	6.0	_	160.0	



# 12.4. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = 25$ °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Note	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
Phase difference	Φι/Ο		_	GND	2.0	_	25	60	ns
between input to output				GND	4.5	_	6	12	
				GND	6.0	_	5	10	
				-4.5	4.5	_	4	_	
Output enable time	t <sub>PZL</sub> ,		$R_L = 1 \text{ k}\Omega$	GND	2.0	_	50	225	ns
	t <sub>PZH</sub>		See 13. AC Test Circuit, Figure 1	GND	4.5	_	14	45	
			i igule i	GND	6.0	_	12	38	
				-4.5	4.5	_	14	_	
Output disable time	t <sub>PLZ</sub> ,		$R_L = 1 k\Omega$	GND	2.0	_	95	225	ns
	t <sub>PHZ</sub>		See 13. AC Test Circuit, Figure 1	GND	4.5	_	30	45	
			i igule i	GND	6.0	_	26	38	
				-4.5	4.5	_	26	_	
Control input capacitance	C <sub>IN</sub>		_	_	_	_	5	10	pF
Common terminal capacitance	C <sub>IS</sub>		See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	11	20	pF
Switch terminal capacitance	Cos		See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	7	15	рF
Feedthrough capacitance	C <sub>IOS</sub>		See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	0.75	2	pF
Power dissipation capacitance	C <sub>PD</sub>	(Note 1)	See 13. AC Test Circuit, Figure 2	GND	5.0	_	10	_	pF

Note 1:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.  $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{|N} + I_{CC}$ 

# 12.5. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between input	Ψι/Ο	_	GND	2.0	_	75	ns
to output			GND	4.5	_	15	
			GND	6.0	_	13	
			-4.5	4.5	_	_	
Output enable time	$t_{PZL}, t_{PZH}$	$R_L = 1 k\Omega$	GND	2.0	_	280	ns
		See 13. AC Test Circuit, Figure 1	GND	4.5		56	
		i iguie i	GND	6.0	_	48	
			-4.5	4.5	_	_	
Output disable time	$t_{PLZ}, t_{PHZ}$	$R_L = 1 k\Omega$	GND	2.0		280	ns
		See 13. AC Test Circuit, Figure 1	GND	4.5	_	56	
		i iguie i	GND	6.0		48	
			-4.5	4.5			
Control input capacitance	C <sub>IN</sub>	_	_	_	_	10	pF
Common terminal capacitance	C <sub>IS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0		20	pF
Switch terminal capacitance	C <sub>OS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0		15	pF
Feedthrough capacitance	C <sub>IOS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	2	pF



# 12.6. AC Characteristics (Unless otherwise specified, $C_L = 50$ pF, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Min	Max	Unit
Phase difference between input	Ψι/Ο	_	GND	2.0	_	85	ns
to output			GND	4.5	_	17	
			GND	6.0	_	15	
			-4.5	4.5	_	_	
Output enable time	$t_{PZL}, t_{PZH}$	$R_L = 1 k\Omega$	GND	2.0	_	320	ns
		See 13. AC Test Circuit, Figure 1	GND	4.5	_	64	
		i iguie i	GND	6.0	_	55	
			-4.5	4.5	_	_	
Output disable time	$t_{PLZ}, t_{PHZ}$	$R_L = 1 k\Omega$	GND	2.0	_	320	ns
		See 13. AC Test Circuit, Figure 1	GND	4.5	_	64	
		i iguie i	GND	6.0	_	55	
			-4.5	4.5	_	_	
Control input capacitance	C <sub>IN</sub>	_	_	_	_	10	pF
Common terminal capacitance	C <sub>IS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	20	pF
Switch terminal capacitance	C <sub>OS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	15	pF
Feedthrough capacitance	C <sub>IOS</sub>	See 13. AC Test Circuit, Figure 2	-5.0	5.0	_	2	pF

## 12.7. Analog Switch Characteristics (T<sub>a</sub> = 25 °C) (Note)

Characteristics	Symbol	Test Condition		Note	V <sub>EE</sub> (V)	V <sub>CC</sub> (V)	Тур.	Unit
Sine Wave Distortion	THD	$R_L = 10 \text{ k}\Omega, C_L = 50 \text{ pF}$	$V_{IN} = 4.0 V_{p-p}$		-2.25	2.25	0.025	%
		f <sub>IN</sub> = 1 kHz	$V_{IN} = 8.0 V_{p-p}$		-4.5	4.5	0.020	
			$V_{IN} = 11.0 V_{p-p}$		-6.0	6.0	0.018	
Maximum frequency	f <sub>MAX(I/O)</sub>	Adjust f <sub>IN</sub> voltage to obtain 0		(Note 1)	-2.25	2.25	120	MHz
response		dBm at V <sub>OS</sub> Increase f <sub>IN</sub> frequency until		(Note 2)	-2.25	2.25	95	
		dB meter reads -3 dB		(Note 1)	-4.5	4.5	190	
		$R_L = 50 \Omega$ , $C_L = 10 pF$		(Note 2)	-4.5	4.5	150	
		f <sub>IN</sub> = 1 MHz, sine wave See 13. AC Test Circuit,		(Note 1)	-6.0	6.0	200	
		Figure 3		(Note 2)	-6.0	6.0	190	
Feed through attenuation (switch OFF)	FTH	V <sub>IN</sub> is centered at (V <sub>CC</sub> - V <sub>EE</sub> )/2			-2.25	2.25	-50	dB
		Adjust input for 0 dBm. $R_L = 600 \Omega$ , $C_L = 50 pF$ , $f_{IN} = 1 MHz$ , sine wave			-4.5	4.5	-50	
		See 13. AC Test Circuit, Figure 4			-6.0	6.0	-50	
Crosstalk (control input to signal output)	X <sub>talk</sub>	$R_L = 600 \Omega, C_L = 50 pF,$ $f_{IN} = 1 MHz,$			-2.25	2.25	60	mV
signal output)		square wave (t <sub>r</sub> = t <sub>f</sub> = 6 ns)			-4.5	4.5	140	
		See 13. AC Test Circuit, Figure 5			-6.0	6.0	200	
Crosstalk (between any switches)	X <sub>talk</sub>	Adjust V <sub>IN</sub> to obtain 0 dBm at input.			-2.25	2.25	-50	dB
,		$R_L = 600 \Omega$ , $C_L = 50 pF$ , $f_{IN} = 1 MHz$ , sine wave			-4.5	4.5	-50	
		See 13. AC Test Circuit, Figure 6			-6.0	6.0	-50	

Note: These characteristics are determined by design of devices.

Note 1: Input COMMON terminal, and measured at SWITCH terminal.

Note 2: Input SWITCH terminal, and measured at COMMON terminal.



### 13. AC Test Circuit

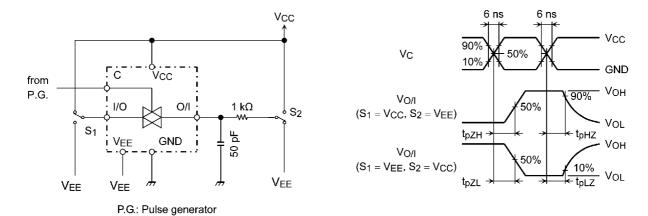


Figure 1 tpLZ, tpHZ, tpZL, tpZH

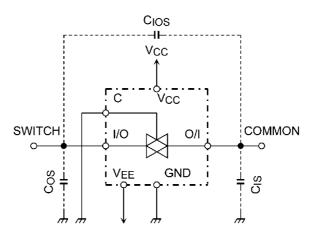


Figure 2 C<sub>IOS</sub>, C<sub>IS</sub>, C<sub>OS</sub>

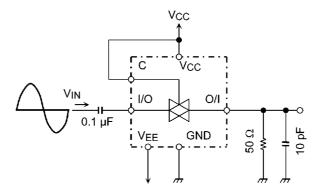


Figure 3 Frequency Response

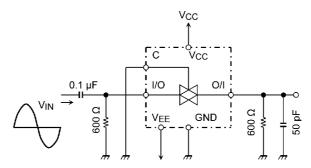
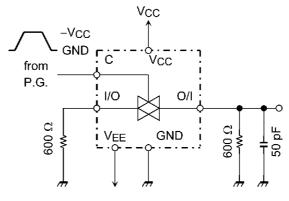


Figure 4 Feedthrough Attenuation





P.G.: Pulse generator

Figure 5 Cross Talk (control input to output signal)

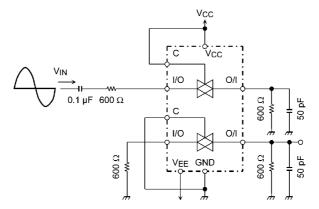
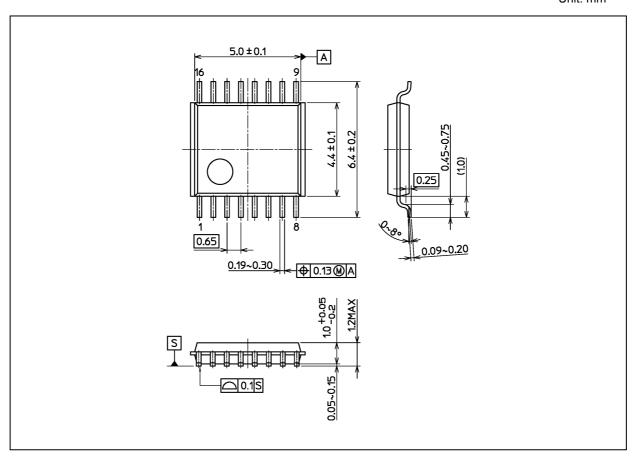


Figure 6 Cross Talk (between any two switches)



## **Package Dimensions**

Unit: mm



Weight: 0.055 g (typ.)

Р	ackage Name(s)
Nickname: TSSOP16B	



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